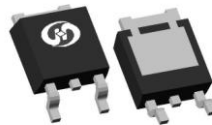
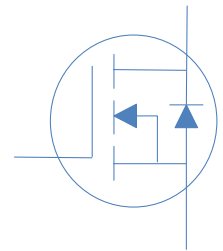


80V N-Ch Power MOSFET

V_{DS}	80	V
$R_{DS(on),typ}$	3.2	m
I_D (Silicon Limited)	144	A
I_D (Package Limited)	120	A



Part Number	Package	Marking
HGD035N08A	TO-252	GD035N08A

Absolute Maximum Ratings at $T_J=25^{\circ}\text{C}$ (unless otherwise specified)

Parameter	Symbol	Conditions	Value	Unit
Continuous Drain Current (Silicon Limited)	I_D	$T_C=25^{\circ}\text{C}$	144	A
		$T_C=100^{\circ}\text{C}$	102	
		$T_C=25^{\circ}\text{C}$	120	
Continuous Drain Current (Package Limited)			120	
Drain to Source Voltage	V_{DS}	-	80	V
Gate to Source Voltage	V_{GS}	-	± 20	V
Pulsed Drain Current	I_{DM}	-	400	A
Avalanche Energy, Single Pulse	E_{AS}	$L=0.1\text{mH}, T_C=25^{\circ}\text{C}$	80	mJ
Power Dissipation	P_D	$T_C=25^{\circ}\text{C}$	150	W
Operating and Storage Temperature	T_J, T_{stg}	-	-55 to 175	$^{\circ}\text{C}$

Absolute Maximum Ratings

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-Ambient	R_{JA}	46	$^{\circ}\text{C/W}$
Thermal Resistance Junction-Case	R_{JC}	1	$^{\circ}\text{C/W}$



Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\text{ A}$	min		
	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\text{ A}$	2.0		
		$V_{GS}=10V, I_D=20A$	-		
	g_{fs}	$V_{DS}=5V, I_D=20A$	-		
		$V_{GS}=0V, V_{DS}\text{ Open}, f=1MHz$	-		
Dynamic Characteristics					
Input Capacitance	C_{iss}		-	4347	
Output Capacitance	C_{oss}	$V_{GS}=0V, V_{DS}=40V, f=1MHz$	-		
Reverse Transfer Capacitance	C_{rss}		-	28	-
Total Gate Charge	$Q_g(10V)$		-	68	-
Gate to Source Charge	Q_{gs}	$V_{DD}=40V, I_D=20A, V_{GS}=10V$	-	13	- nC
Gate to Drain (Miller) Charge	Q_{gd}		-	17	-
Turn on Delay Time	$t_{d(on)}$		-	15	-
Rise time	t_r	$V_{DD}=40V, I_D=20A, V_{GS}=10V,$	-	12	- ns
Turn off Delay Time	$t_{d(off)}$	$R_G=10\ \Omega$	-	52	-
Fall Time	t_f		-	19	-
Reverse Diode Characteristics					
Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_F=20A$	-	0.9	1.2 V

Fig 1. Typical Output Characteristics

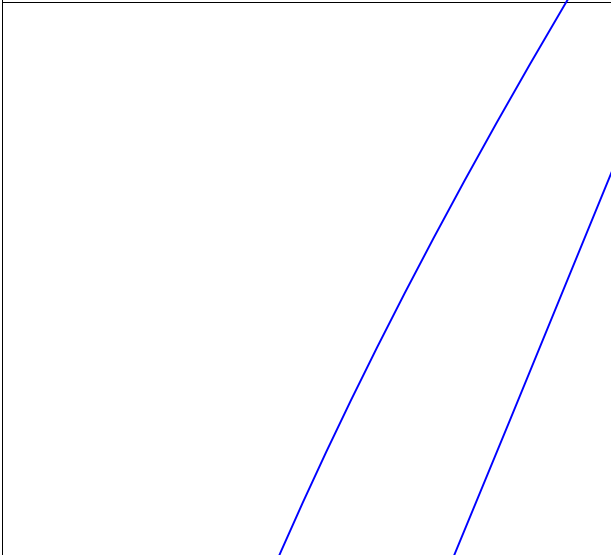


Figure 2. On-Resistance vs. Gate-Source Voltage

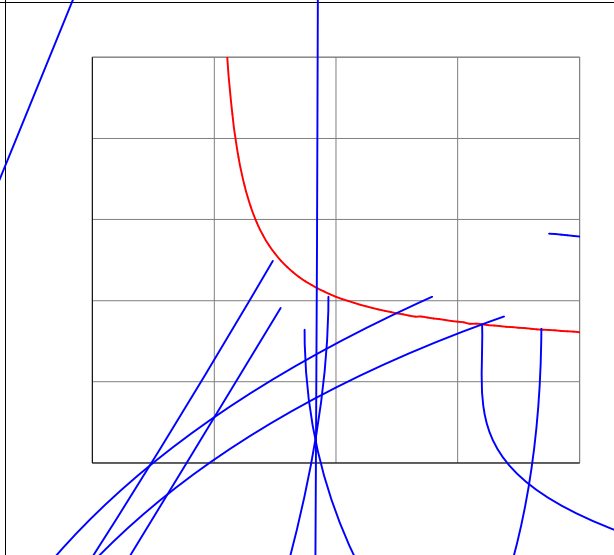


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

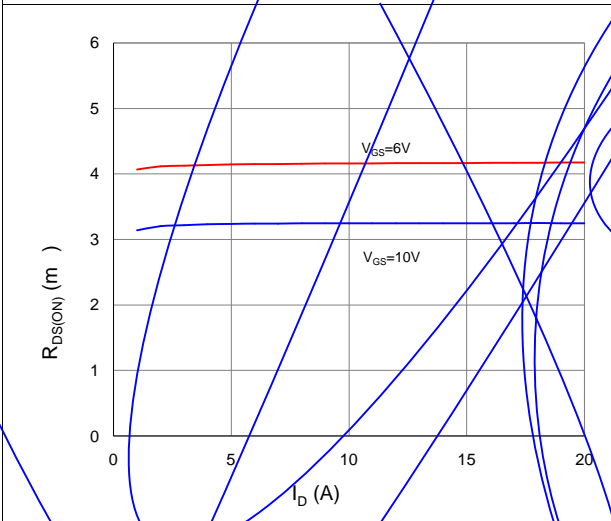


Figure 4. Normalized On-Resistance vs. Junction Temperature

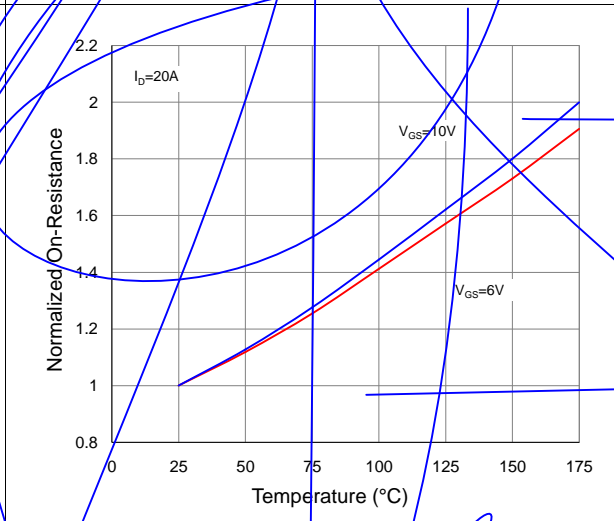


Figure 5. Typical Transfer Characteristics

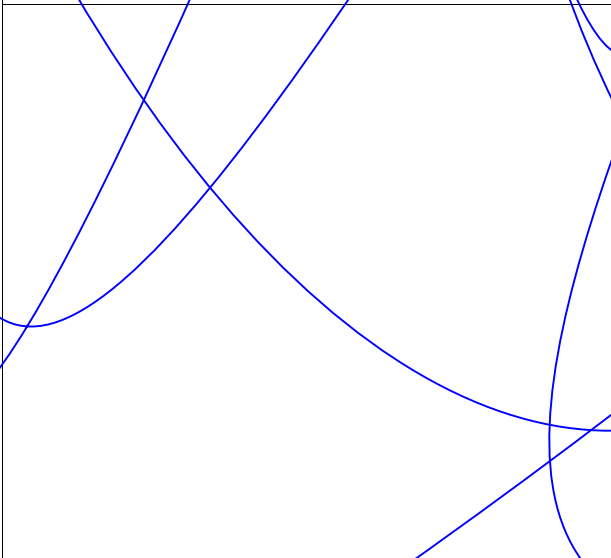


Figure 6. Typical Source-Drain Diode Forward Voltage

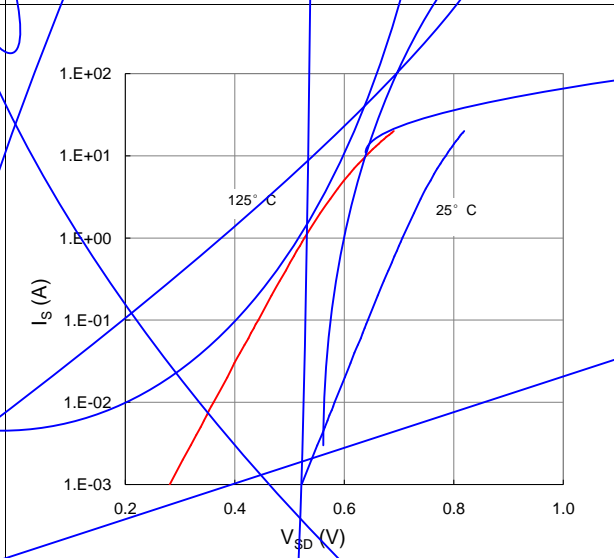


Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

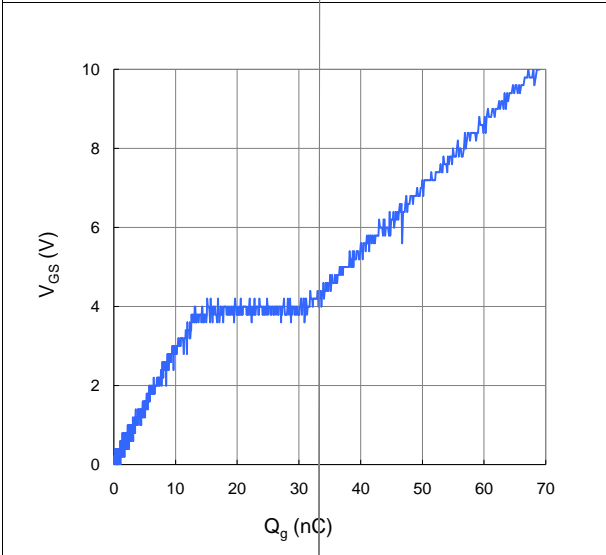


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

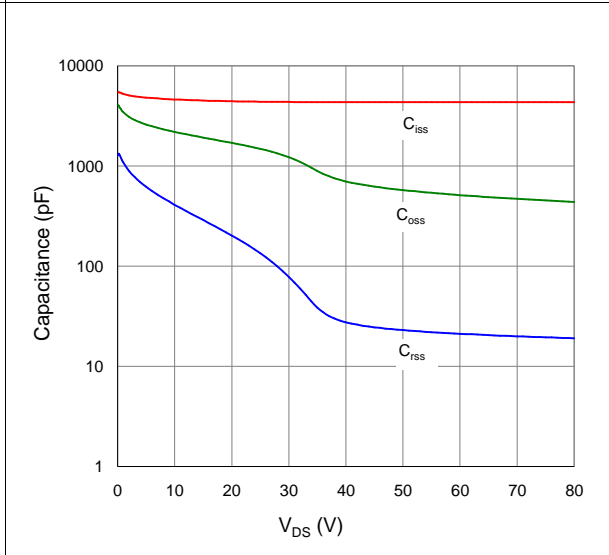


Figure 9. Maximum Safe Operating Area

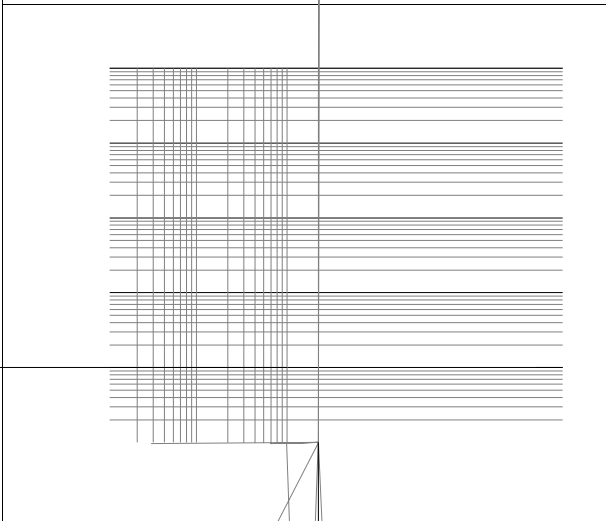


Figure 10. Maximum Drain Current vs. Case Temperature

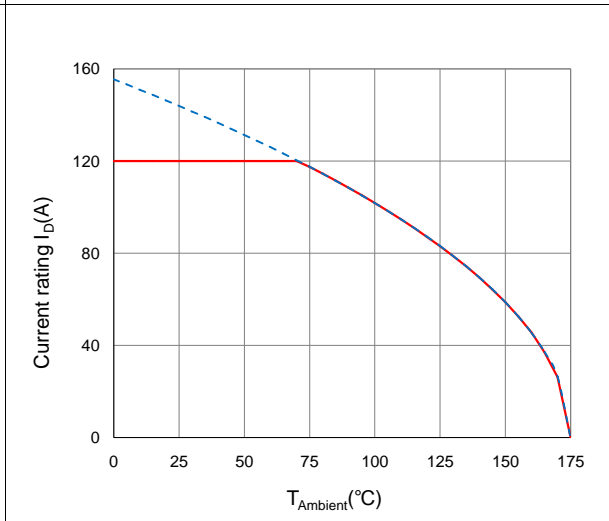
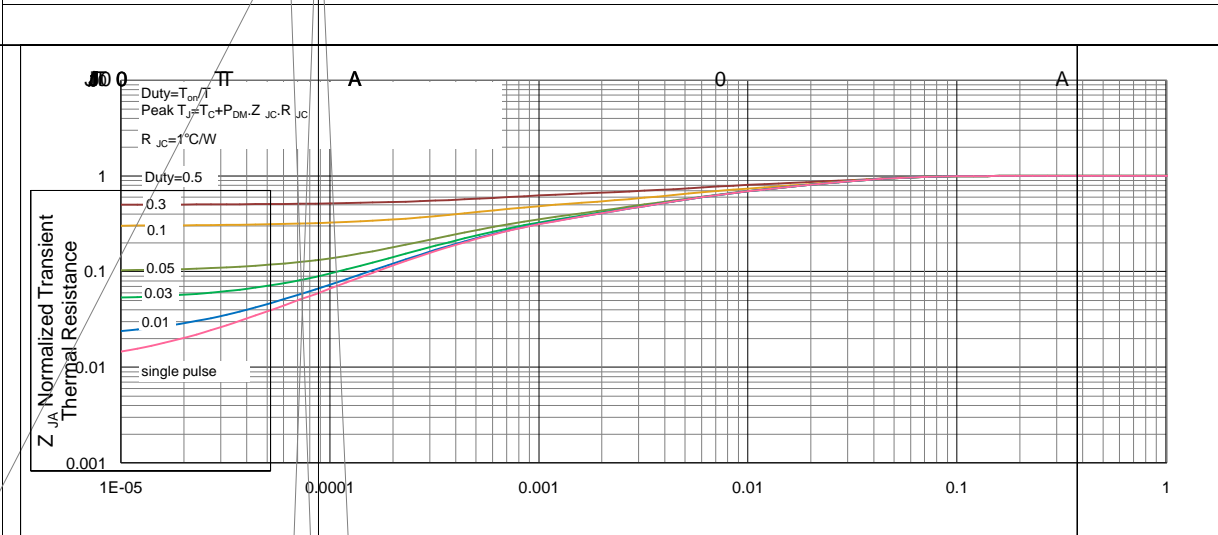


Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Ambient



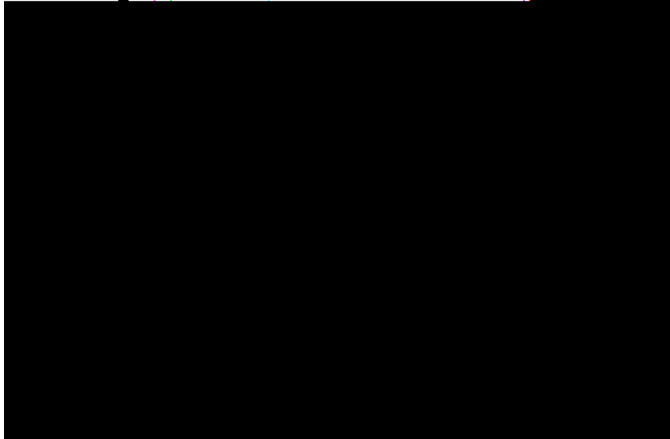
Inductive switching Test

Gate Charge Test

Uclamped Inductive Switching (UIS) Test

Package Outline

TO-252, 3 leads



SYMBOL	DIMENSIONAL REQMTS		
	MIN	NOM	MAX
E	6.40	6.60	6.731
L	1.40	1.52	1.77
L1	2.743 REF		
L2	0.508 BSC		
L3	0.89	--	1.27
L4	0.64	--	1.01
L5	--	--	--
D	6.00	6.10	6.223

